

| | | | |
|-----------------------------------|---------------------------------------|---------------------------------------------------------------|-------------|
| Notice of References Cited | Application/Control No. 10/821,736 | Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL. | |
| | Examiner Mark J. Beauchaine | Art Unit 3653 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|------------------|----------------|
| * | A | US-2004/0084521 | 05-2004 | Nagayoshi et al. | 235/379 |
| * | B | US-6,363,164 | 03-2002 | Jones et al. | 382/135 |
| * | C | US-6,000,555 | 12-1999 | Anma, Hideyuki | 209/534 |
| * | D | US-5,909,814 | 06-1999 | Arikawa, Junichi | 209/534 |
| * | E | US-5,135,212 | 08-1992 | Utsumi et al. | 271/3.03 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.